

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/687,288	YUEH ET AL.	
Examiner	Art Unit	
Daborah Chacko-Davis	1756	

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated text search only-see updated search history print out	5/4/2006	DCD		
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)-see search history print out	5/4/2006	DCD		
Updated search history print out	5/5/2006	DCD		
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